

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10074117	BUCHNER ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Son P. Huynh	2424

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
725	152-153, 112, 141-142, 89-90, 115	9/29/06	JM
386	33, 46	9/29/06	JM
725	78,80,131,133,139,141,151,153	3/30/07	AH
386	46,83	3/30/07	AH
	update search	10/16/07	AH
	update search	7/16/08	AH
725	78,80,82,68,71,100,131,133,139,141,151,153	7/16/08	AH
	update search performed	1/5/09	AH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Search	9/29/06	JM
Spoke with Scott Beliveau and Chris Lambrecht	9/29/06	JM
East text searched enclosed	3/30/07	AH
Update East Text Search enclosed	10/16/07	AH
Update Text Search Enclosed	7/16/08	AH
Update EAST text search enclosed	1/5/09	AH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>